## Notice of References Cited Application/Control No. 10/815,516 Examiner Alan S. Chen Applicant(s)/Patent Under Reexamination CAIN ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,754,112 A	05-1998	Novak, Vit F.	340/635
*	В	US-2005/0160213 A1	07-2005	Chen, Ben Wei	710/305
*	С	US-2005/0044220 A1	02-2005	Madhavan, Sajeev	709/225
	D	US-			
	Ε	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	7	US-			
	к	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name .	Classification
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	σ					
	R					
	S					
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## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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